Specifications

to the HP 4274A & HP 4275A data sheet for digitals.

Parameters Measured

L'intactorica	Q: =1/0	8: phase angle
D'apportance	EIR equipplent suries	2: deviation for L. C.
R resistance It impedance It dissipation factor	G: conductance X: rescratce B: susceptance	IL Z, Affi: % of deviation

Measurement Range

MODEL	HP 4274A	HP 4275A
L	100.00 nH - 1000.0 H	100.00 = H - 10.00 H
C	1.0000 pF - 1.00 F	1.0000 pF - 100.00 pF
R IZL ESR, & X	100.00 mH - 10.000 M2	1.0000 Q - 10.000 MII
D	0.00001 - 9.9999	0.0001 - 9.9999
Q (1/D)	0.01 - 9900	0.01 - 9900
G & B	1.0000 µS - 100.00 S	1.0000 pS - 10.00 S
e	0 - ±180*	0 - ±180°

Measurement Accuracy

	C-D/Q	L-0/0
RANGE RANGE	O range: 0 00001-9 9993 Q-range: 0.01-9900 (=1/0) (C & D iccuracies apply only when C: full scale and B is 0.1)	B-range: 0.00001-9.5999 0-range: 0.01-9900 (+1/0) (1.6 B accuracies apply anly when L; full scale and 0 = 0.11

HP 42743

120 Hz	C: 1000 pF-1000 mF, 0.1% + 3 D: 0.33% + 0.0008 + 1	1: 100 pH-20 kH 0.1% +3 0: 0.33% + 0.0013 + 1
200 Hz	C 1000 pF-1000 mF, 0.1% + 2 D 0.32% + 0.0007 + 1	L: 100 aH-10 kH, 0.1% + 3 D: 0.32% + 0.0012 + 1
400 Hz	C: 100 pF 100 mF; 0.14% + 1 D: 0.34% + 0.0013 = 1	b: 100 ±4-10 kH, 0.1% + 3 0: 0.11% + 0.00 H + 1
186	C: 100 pF-100 mF, 0.1% + 3 D: 0.33% + 0.0008 v 1	L: 10 aH-1000 H, D.1% + 3 D: 0.33% + 0.0013 + 1
2.647	C: 100 pF-100 mF, 0.1% + 2 D: 0.32% + 0.0007 + 1	L: 10 aH-1000 H; 0.1% + 3 D: 0.32% + 0.0012 + 1
4 kHz	C: 10 pF-10 mF, 0.14% + 1 D: 0.34% + 0.00(3 + 1	L: 10 pH-1000 H; 0.1% + 3 B: 0.31% + 0.0011 + 1
10310	C: 10 pF-10 mF, 0.1% + 3 D: 0.33% + 0.0008 + 1	1: 1 att 100 H, 0.19, + 3 0: 0.33% + 0.0013 + 1
70 km2	C: 10 pf-19 nf, 0.1% + 2 D: 0.32% + 0.0007 + 1	L: 1 ₂ H-100 H: 0.1% = 3 0: 0.32% + 0.0012 + 1
和班	C: 3 pf-1000 aF, 0,14% + 1 D: 0.34% + 0.0013 + 1	L: 1 #H-100 H: Q:1% + 3 D: Q:31% + 0:0011 + 1
100 AHT	© TpF-1000pF, 0:1% + 3 0: 0:33% + 0:0008 + 1	C: 100 cH-10 H; 0.1% + 3 O: 0.33% + 0.0013 + 1

-	MP 4275A			
10 kHz	C: 10 pF-100 pF, 0.1% + 3 D: 0.03% + 0.008 + 1	L: 10 _F H-100H, D:1% + 3 D: 0.33% + 0.0013 + 1		
27 1/2	C: 10 pF-100 µF; 0 1% + 2 D: 0 32% + 0.0007 + 1	L: 10,4H-100 H; 0.1% + 3 0: 0.32% + 0.00(2 + 1		
40 KHz	C) 1 pF-10 a5, 0,14% + 1 B: 0.34% + 0,0009 + 1	L: 10 pH - 100 PL 0.1% + 3 D: 0.31 % + 0.001 + 1		
330 Kiz	C 1 pF-10 pF, 0.1% + 3 0: 0.33% + 0.0008 + 1	1:1±H-10H-01%+3 0:0335+00013+1		
200 MIz	C: 10 pf-10 aF, 0.1% + 2 D: 0.32% + 0.0007 + 1	U L ptr = 1000 set (0.2% + 3 B: 0.52% + 0.0023 + 1		
450 100	C 1 pF-1000 eF, 0.14% + [0: 0.34% + 0.0009 + 1	1: 1 att - 1000 mH, 0 2% + 3 0: 0.51 % + 0.0021 + 1		
1 WHi	C: 1 pF-1000 nF, 0.1% + 3 C: 0.33% + 0.0008 + 1	C: 100+H - 100 mH, 0.2% + 3 C: 0.55% + 0.0025 + 1		
2.846	C: 10 pF-100 nF, 0.3% + 3 D: 0.55% + 0.0025 + 1	1: 1 µH = 10 mH, 0.5% + 5 0: 1:0% + 0.0033 + 1		
41642	0: 1 pF-10 nF 1% + 20 + 0.000 pF 0: 13% + 0.01 + 1	1: 1 #H - 10 mit, 1% + 5 . 2: 2:0% + 0:0061 + 1		
10 MHz	C: Lpt-10 tF, 29, + 20 + 0 t02 pF C: 49, + 0.011 + 1	L: 100 rH - 1 mH, 2% + 7 D: 3.1% + 0.000 + 1		

Rarge full scale range, accuracy: % of reading + counts (D accuracy: For reading + absolute D value + count).

Controls Warm-up time > 00 minutes, environment temperature: 20°C ± 5°C). light to technical data shoot for accuracy details.

Measurement Frequencies

HP 4274A; 100 Hz-100 kHz, 11 spots (100 Hz, 120 Hz, 200 Hz, 400 Hz, 1 kHz, 2 kHz, 4 kHz, 10 kHz, 20 kHz, 40 kHz, 100 kHz; ±0.01%)

HP 4275A: 10 kHz-10 MHz, 10 sputs (10 kHz, 20 kHz, 40 kHz, 100 kHz, 200 kHz, 400 kHz, 1 MHz, 2 MHz, 4 MHz, 10 MHz; ±0.01%)

Test Signal Level:

HP 4274A: 4-ranges (1 mVrms-5 Vrms) continuously variable HP 4275A: 3-ranges (1 mVrms-1 Vrms) continuously variable Test Signal Level Monitor: standard.

Displays: dual 51/5-digit and single 3-digit; maximum display 199999 (full scale and overrange in high resolution mode), and 41/i-digit: maximum display 19999 in normal mode. (Number of digits depends on measurement frequency, test level, and range).

lel equivalent circuit. Automatic selection available in AUTO mode. Deviation measurement: difference between recallable stored reference and displayed is deviation value (count or percent).

Ranging: AUTO or MANUAL (UP/DOWN)

Trigger: internal, external or manual.

Measurement terminals: four-terminal pair with guard. Auto zero adjustment: automatic normalization of the readout offset due to residuals of the test fixture by pushbutton operation. Normalization range: C < 20 pF, L < 2000 nH, $R < 0.5\Omega$, $G < 5 \mu S$. Self test: automatic operational verification check indicates pass or fail condition.

Reference Data

Measurement time: (typical) 140-180 ms (>1 kHz); 140-210 ms ≤1 kHz (measurement time depends on range, sample value and offset adjustment value).

Z = θ measurement time: 170-210 ms >1 kHz; 170-240 ms ≤1 kHz.

High resolution mode: approximately 8 times the normal measurement time.

Auto ranging time: 100 ms - 300 ms per range change.

General Information

Operating Temperature and Humidity: 0°C - 55°C. ≤95% RH at 40°C

Power: 100, 120, 220V ±10%, 240V + 5% - 10%, 48 - 66Hz, 135VA max. (HP 4274A); 165VA max. (HP 4275A) Size: 177H x 425W x 574Dmm (7" x 16.75" x 22.6")

Weight: 18kg (39.6lbs)

Accessory Furnished

HP 16047A: Direct coupled test fixture.

Accessory Available

HP 16023B: de Bias Controller, for control of de bias 5350富 Opt 001 or 002 Internal Bias Supply.

One or two arbitrary test frequencies for each instrument are available. For more details, please contact nearest HP sales office.

Selectable Frequency Range

HP 4274A: 100 Hz to 100 kHz to ±0.1%. If two frequencies are added, at least one frequency must satisfy the following equation: f =1200/N kHz where N is an integer from 12 to 12000. HP 4275A1

Ordering

HP 4274A Opt W30: 3 HP 4275A Opt W30; 3 Opt 001: 0 1 mV steps Opt 002: 0 100 mV ste Opt 004: F

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